

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10567481	SHEN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	M. Lee	2622

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	725, 552-558, 705, 706	8/29/08	ml

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
east	8/29/08	ml

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/M. Lee/ Primary Examiner.Alt Unit 2622
--	--